

N-Channel Super Junction Power MOSFET

General Description

The series of devices use advanced super junction technology and design to provide excellent R_{DS(ON)} with low gate charge. This super junction MOSFET fits the industry's AC-DC SMPS requirements for PFC, AC/DC power conversion, and industrial power applications.

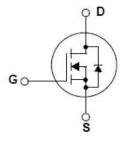
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- New technology for high voltage device
- ●Low on-resistance and low conduction losses
- ●Small package
- •Ultra Low Gate Charge cause lower driving requirements
- ●100% Avalanche Tested
- ●ROHS compliant

Application

- Power factor correction (PFC)
- Switched mode power supplies(SMPS)
- Uninterruptible Power Supply (UPS)

V _{DS} @ T_{jmax}	650	V
R _{DS(ON) MAX}	180	mΩ
I_D	21	A



Schematic diagram

Package Marking And Ordering Information

Device	Device Package	Marking
HMS21N60A	TO-3P	HMS21N60A



Table 1. Absolute Maximum Ratings (T_c=25℃)

Parameter	Symbol	HMS21N60A	Unit
Drain-Source Voltage (VGs=0V)	V _{DS}	600	V
Gate-Source Voltage (V _{DS} =0V)	V _G s	±30	V
Continuous Drain Current at Tc=25°C	I _{D (DC)}	21	Α
Continuous Drain Current at Tc=100°C	I _{D (DC)}	13.2	Α
Pulsed drain current (Note 1)	I _{DM (pluse)}	63	Α
Maximum Power Dissipation(Tc=25℃)	P _D	200	W
Derate above 25°C		1.6	W/°C
Single pulse avalanche energy (Note 2)	Eas	690	mJ
Avalanche current ^(Note 1)	I _{AR}	7	А
Repetitive Avalanche energy , t_{AR} limited by T_{jmax} (Note 1)	E _{AR}	1	mJ



Parameter	Symbol	HMS21N60A	Unit
Drain Source voltage slope, V _{DS} ≤480 V,	dv/dt	50	V/ns
Reverse diode dv/dt, $V_{DS} \le 480 \text{ V,I}_{SD} < I_{D}$	dv/dt	15	V/ns
Operating Junction and Storage Temperature Range	T_J, T_{STG}	-55+150	°C

^{*} limited by maximum junction temperature

Table 2. Thermal Characteristic

Parameter	Symbol	HMS21N60A	Unit
Thermal Resistance, Junction-to-Case (Maximum)	R _{thJC}	0.62	°C /W
Thermal Resistance, Junction-to-Ambient (Maximum)	R _{thJA}	62.5	°C /W

Table 3. Electrical Characteristics (TA=25℃ unless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit
On/off states						
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V I _D =250μA	600			V
Zero Gate Voltage Drain Current(Tc=25℃)	I _{DSS}	V _{DS} =600V,V _{GS} =0V		0.05	1	μA
Zero Gate Voltage Drain Current(Tc=125℃)	I _{DSS}	V _{DS} =600V,V _{GS} =0V			100	μΑ
Gate-Body Leakage Current	I _{GSS}	V _{GS} =±30V,V _{DS} =0V			±100	nA
Gate Threshold Voltage	V _{GS(th)}	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$	2.5	3	3.5	V
Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =10V, I _D =10.5A		150	180	mΩ
Dynamic Characteristics						
Forward Transconductance	g FS	V _{DS} = 20V, I _D = 10.5A		17.5		S
Input Capacitance	C _{lss}	\/ -50\/\/ -0\/		1950		PF
Output Capacitance	C _{oss}	- V _{DS} =50V,V _{GS} =0V, - F=1.0MHz		150		PF
Reverse Transfer Capacitance	C _{rss}	F=1.UIVIDZ		5		PF
Total Gate Charge	Qg	V _{DS} =480V,I _D =21A,		45	70	nC
Gate-Source Charge	Q _{gs}	V_{DS} =460V, I_D =21A, V_{GS} =10V		9		nC
Gate-Drain Charge	Q_{gd}	V _{GS} -10V		18		nC
Intrinsic gate resistance	R_G	f = 1 MHz open drain		1		Ω
Switching times						
Turn-on Delay Time	t _{d(on)}			11		nS
Turn-on Rise Time	t _r	V _{DD} =380V,I _D =11A,		6		nS
Turn-Off Delay Time	$t_{d(off)}$	$R_G=4\Omega, V_{GS}=10V$		61	100	nS
Turn-Off Fall Time	t _f			4.5	12	nS
Source- Drain Diode Characteristics						
Source-drain current(Body Diode)	I _{SD}	T _C =25°C			21	Α
Pulsed Source-drain current(Body Diode)	I _{SDM}	1 _C -25 C			63	Α
Forward on voltage	V _{SD}	Tj=25°C,I _{SD} =21A,V _{GS} =0V		0.9	1.3	V
Reverse Recovery Time	t _{rr}			310		nS
Reverse Recovery Charge	Q _{rr}	Tj=25°C,I _F =21A,di/dt=100A/μs		5		uC
Peak Reverse Recovery Current	I _{rrm}			28		Α

Notes 1.Repetitive Rating: Pulse width limited by maximum junction temperature

 $[\]textbf{2}. \ \, \mathsf{Tj}\texttt{=}25\,^\circ\!\!\!\!\!\!\!^\circ,\mathsf{VDD}\texttt{=}50\mathsf{V},\mathsf{VG}\texttt{=}10\mathsf{V},\,\mathsf{R}_{\mathsf{G}}\texttt{=}25\Omega$



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS (curves)

Figure 1. Safe operating area

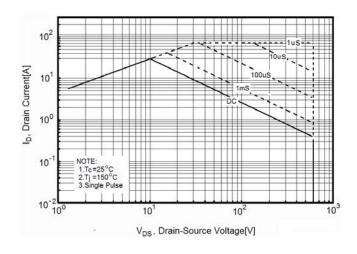


Figure 3. Source-Drain Diode Forward Voltage

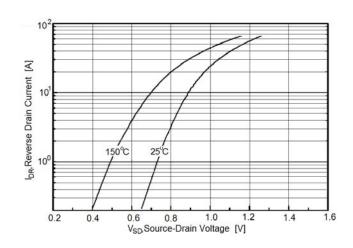


Figure 4. Output characteristics

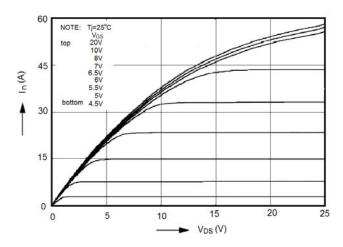


Figure 5. Transfer characteristics

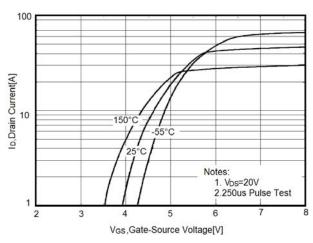


Figure 6. Static drain-source on resistance

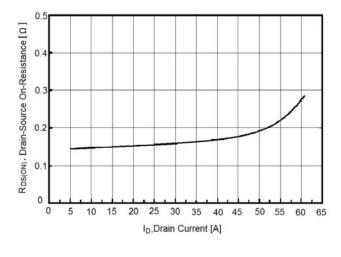


Figure 7. R_{DS(ON)} vs Junction Temperature

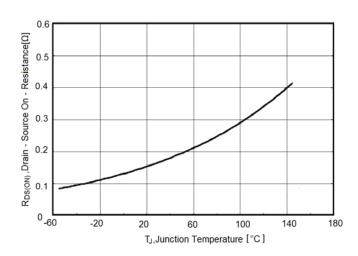




Figure 8. BV_{DSS} vs Junction Temperature

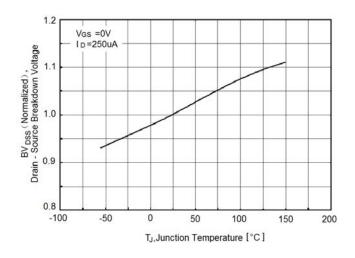


Figure 9. Maximum I_D vs Junction Temperature

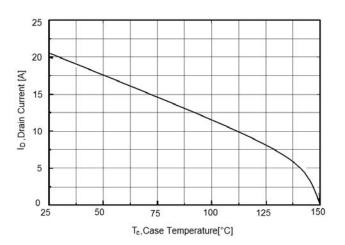


Figure 10. Gate charge waveforms

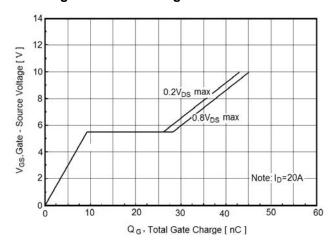


Figure 11. Capacitance

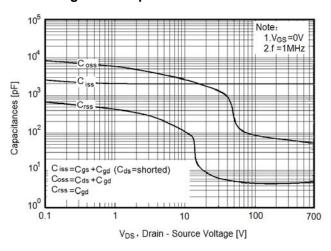
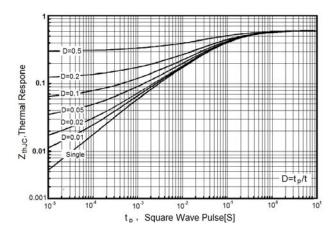


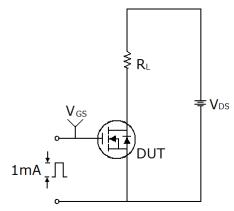
Figure 12. Transient Thermal Impedance

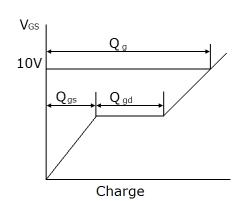




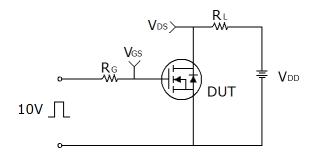
Test circuit

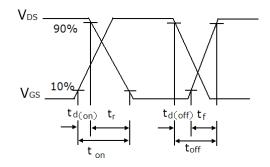
1) Gate charge test circuit & Waveform



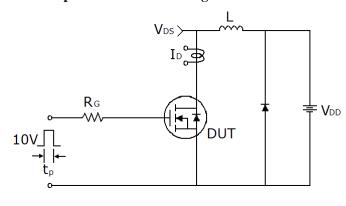


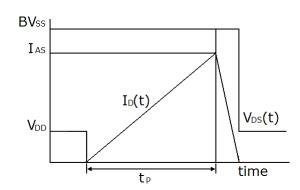
2) Switch Time Test Circuit:





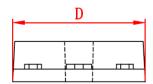
3) Unclamped Inductive Switching Test Circuit & Waveforms

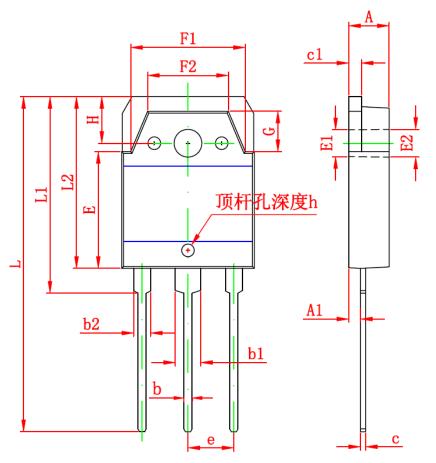


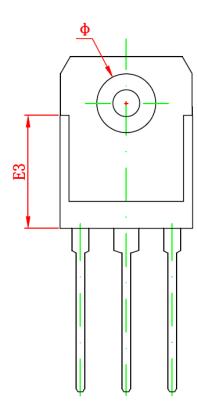




TO-3P PACKAGE OUTLINE DIMENSIONS







0 h. a.l	D im ensions	In Millimeters	D im ensior	is In Inches	
Symbol	Min	Мах	Min	Max	
Α	4.600	5.000	0.181	0.197	
A 1	1.200	1.600	0.047	0.063	
b	0.800	1.200	0.031	0.047	
b 1	2.800	3.200	0.110	0.126	
b 2	1.800	2.200	0.071	0.087	
С	0.500	0.700	0.020	0.028	
c 1	1.450	1.650	0.057	0.065	
D	15.450	15.850	0.606	0.622	
E	13.700	14.100	0.539	0.555	
E 1	3.200	REF	0.126 REF		
E 2	3.300	REF	0.130 REF		
E 3	13.45	0 REF	0.530 REF		
F 1	13.400	13.800	0.528	0.543	
F 2	9.400	9.800	0.370	0.386	
L	39.900	40.300	1.571	1.587	
L 1	23.200	23.600	0.913	0.929	
L 2	20.300	20.600	0.799	0.811	
Φ	6.900	7.100	0.272	0.280	
G	5.150	5.550	0.203	0.219	
е	5.450 TYP		0.21	5 TYP	
Н	5.000	5.000 REF		7 REF	
h	0.000	0.300	0.000	0.012	

HMS21N60A



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